

**Search Notes**

Application/Control No.

10/812,972

Examiner

Eric Chang

Applicant(s)/Patent under  
Reexamination

NIEN ET AL.

Art Unit

2116

**SEARCHED**

Class	Subclass	Date	Examiner
713	320	11/22/2007	EC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST USPAT/PGPUB EPO/JPO	11/22/2007	EC